onsemi

Silicon Carbide (SiC) **Cascode JFET** – EliteSiC, Power N-Channel, TO247-4, 650 V, 42 mohm

UF3C065040K4S

Description

onsemi's cascode products co-package its high-performance F3 SiC fast JFETs with a cascode optimized MOSFET to produce the only standard gate drive SiC device in the market today. This series exhibits very fast switching using a 4-terminal TO247- package and the best reverse recovery characteristics of any device of similar ratings. These devices are excellent for switching inductive loads, and any application requiring standard gate drive.

Features

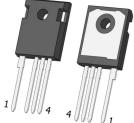
- Typical On-resistance R_{DS(on)typ} of 42 mΩ
- Maximum Operating Temperature of 175 °C
- Excellent Reverse Recovery
- Low Gate Charge
- Low Intrinsic Capacitance
- ESD Protected, HBM Class 2
- TO247-4 Package for Faster Switching, Clean Gate Waveforms
- This Device is Pb-Free, Halogen Free and is ROHS Compliant

Typical Applications

- EV Charging
- PV Inverters
- Switch Mode Power Supplies
- Power Factor Correction Modules
- Motor Drives
- Induction Heating

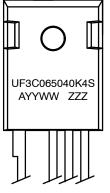
www.onsemi.com

DATA SHEET



TO247-4 15.90x20.96x5.03. 5.44P CASE 340AN

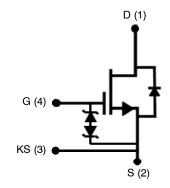
MARKING DIAGRAM



UF3C065040K4S = Specific Device Code

А	= Assembly Location
YY	= Year
WW	= Work Week
ZZZ	= Lot ID

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 8 of this data sheet.

MAXIMUM RATINGS

Parameter	Symbol	Test Conditions	Value	Unit
Drain-source Voltage	V _{DS}		650	V
Gate-source Voltage	V _{GS}	DC	-25 to +25	V
Continuous Drain Current (Note 1)	I _D	T _C = 25 °C	54	А
		T _C = 100 °C	40	А
Pulsed Drain Current (Note 2)	I _{DM}	T _C = 25 °C	125	А
Single Pulsed Avalanche Energy (Note 3)	E _{AS}	L = 15 mH, I _{AS} = 3.19 A	76	mJ
Power Dissipation	P _{tot}	T _C = 25 °C	326	W
Maximum Junction Temperature	T _{J,max}		175	°C
Operating and Storage Temperature	T _J , T _{STG}		–55 to 175	°C
Max. Lead Temperature for Soldering, 1/8" from Case for 5 Seconds	ΤL		250	°C

 I
 I
 I
 I

 Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
 If any of these limits are exceeded, device functionality may be affected.

 1.
 Limited by $T_{J,max}$ Imited by $T_{J,max}$

 2.
 Pulse width t_p limited by $T_{J,max}$

 3.
 Starting $T_J = 25 \ ^\circ C$

THERMAL CHARACTERISTICS

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{ extsf{ heta}JC}$		-	0.35	0.46	°C/W

ELECTRICAL CHARACTERISTICS (T_J = +25 °C unless otherwise specified)

Parameter	Symbol Test Conditions		Min	Тур	Max	Unit
TYPICAL PERFORMANCE - STATIC						
Drain-source Breakdown Voltage	BV _{DS}	BV_{DS} $V_{GS} = 0 V, I_D = 1 mA$		-	-	V
Total Drain Leakage Current	I _{DSS}	V_{DS} = 650 V, V_{GS} = 0 V, T_{J} = 25 $^{\circ}C$	-	0.7	150	μΑ
		V_{DS} = 650 V, V_{GS} = 0 V, T_{J} = 175 $^{\circ}C$	-	10	-	
Total Gate Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS} = -20 V / +20 V	-	6	±20	μΑ
Drain-source On-resistance	R _{DS(on)}	V_{GS} = 12 V, I_D = 40 A, T_J = 25 $^\circ C$	-	42	52	mΩ
		V_{GS} = 12 V, I _D = 40 A, T _J = 125 °C	-	59	-	
		V_{GS} = 12 V, I_D = 40 A, T_J = 175 $^\circ C$	-	78	-	
Gate Threshold Voltage	V _{G(th)}	V _{G(th)} V _{DS} = 5 V, I _D = 10 mA		5	6	V
Gate Resistance R _G		f = 1 MHz, open drain	-	4.5	-	Ω
TYPICAL PERFORMANCE – REVERSE DIO	DE					
Diode Continuous Forward Current (Note 4)	I _S	$T_{\rm C}$ = 25 °C	-	-	54	А
Diode Pulse Current (Note 5)	I _{S,pulse}	S,pulse $T_C = 25 \ ^{\circ}C$		-	125	А
Forward Voltage	V _{FSD}	V_{GS} = 0 V, I_S = 20 A, T_J = 25 $^\circ C$	-	1.5	1.75	V
		V_{GS} = 0 V, I_S = 20 A, T_J = 175 $^\circ C$	-	1.8	-	
Reverse Recovery Charge	Q _{rr}			138	-	nC
Reverse Recovery Time	t _{rr}	R _{G_EXT} = 20 Ω, di/dt = 1100 A/μs, T _J = 25 °C	-	38	-	ns
Reverse Recovery Charge	Q _{rr}	$V_{DS} = 400 \text{ V}, \text{ I}_{S} = 40 \text{ A}, \text{ V}_{GS} = -5 \text{ V},$		137	-	nC
Reverse Recovery Time	t _{rr}	R _{G_EXT} = 20 Ω, di/dt = 1100 A/μs, T _J = 150 °C	-	38	-	ns

ELECTRICAL CHARACTERISTICS (T_J = +25 $^{\circ}$ C unless otherwise specified) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
TYPICAL PERFORMANCE – DYNAMIC						
Input Capacitance	C _{iss}	f = 100 kHz		1500	-	pF
Output Capacitance	C _{oss}			200	-	
Reverse Transfer Capacitance	C _{rss}		-	2.2	-	
Effective Output Capacitance, Energy Related	C _{oss(er)}	V_{DS} = 0 V to 400 V, V_{GS} = 0 V	-	146	-	pF
Effective Output Capacitance, Time Related	C _{oss(tr)}	V_{DS} = 0 V to 400 V, V_{GS} = 0 V	-	325	-	pF
C _{OSS} Stored Energy	E _{oss}	$V_{DS} = 400 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	11.7	-	μJ
Total Gate Charge	Q _G	$V_{DS} = 400 \text{ V}, \text{ I}_{D} = 40 \text{ A},$	-	43	-	nC
Gate-drain Charge	Q _{GD}	$V_{GS} = -5 V$ to 12 V	-	11	-	
Gate-source Charge	Q _{GS}		-	19	-	
Turn-on Delay Time	t _{d(on)}	$\begin{array}{c c} t_{d(on)} & V_{DS} = 400 \; V, \; I_D = 40 \; A, & - \\ & Gate \; Driver = -5 \; V \; to \; +12 \; V, & - \\ \hline t_r & Turn \text{-on } R_{G,EXT} = 8.5 \; \Omega, & - \\ \hline t_{d(off)} & Turn \text{-off } R_{G,EXT} = 20 \; \Omega & - \\ & Inductive \; Load, & - \\ \hline t_f & FWD: \; same \; device \; with \; V_{GS} = -5 \; V, & - \\ & R_G = 10 \; \Omega, \; T_J = 25 \; ^\circ C & - \\ \hline \end{array}$	-	26	-	ns
Rise Time	tr		_	24	-	
Turn-off Delay Time	t _{d(off)}		-	45	-	
Fall Time	t _f		-	10	-	
Turn-on Energy	E _{ON}	11G - 10 52, 1J - 23 O	-	227	-	μJ
Turn-off Energy	E _{OFF}		-	82	-]
Total Switching Energy	E _{TOTAL}		-	309	-	
Turn-on Delay Time	t _{d(on)}	$V_{DS} = 400 \text{ V}, I_{D} = 40 \text{ A},$	-	22	-	ns
Rise Time	t _r	Gate Driver = -5 V to +12 V, Turn-on R _{G,EXT} = 8.5 Ω ,	-	22	-	
Turn-off Delay Time	t _{d(off)}	Turn-off $R_{G,EXT} = 20 \Omega$ Inductive Load,	-	45	-	
Fall Time	t _f	FWD: same device with $V_{GS} = -5 V$,	-	8	-	
Turn-on Energy	E _{ON}	- R _G = 10 Ω, T _J = 150 °C	-	207	-	μJ
Turn-off Energy	E _{OFF}]	-	64	-	
Total Switching Energy	E _{TOTAL}	1	-	271	-	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
4. Limited by T_{J,max}
5. Pulse width t_p limited by T_{J,max}

TYPICAL PERFORMANCE DIAGRAMS

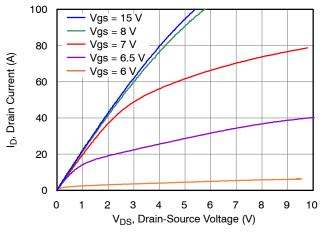


Figure 1. Typical Output Characteristics at T_J = –55 °C, $t_p < 250 \ \mu s$

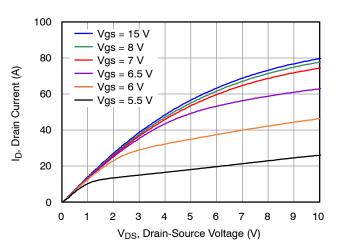


Figure 3. Typical Output Characteristics at T_J = 175 °C, $t_p < 250 \ \mu s$

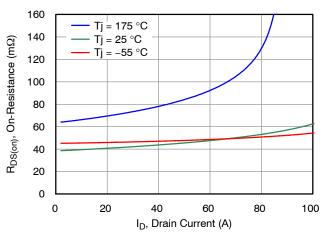
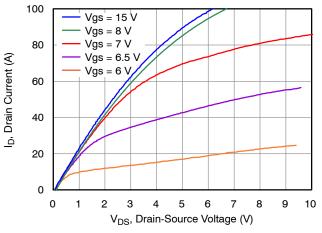
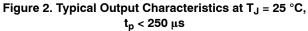


Figure 5. Typical Drain-Source On-Resistances at V_{GS} = 12 V





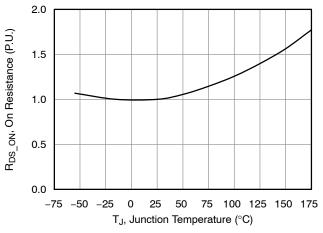


Figure 4. Normalized On-Resistance vs. Temperature at V_{GS} = 12 V and I_D = 40 A

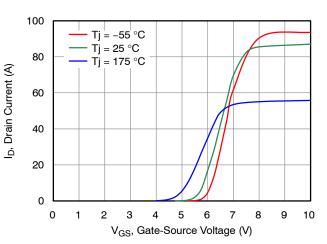
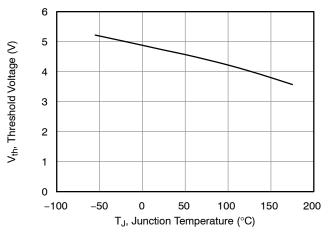
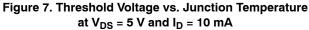


Figure 6. Typical Transfer Characteristics at V_{DS} = 5 V

TYPICAL PERFORMANCE DIAGRAMS (CONTINUED)





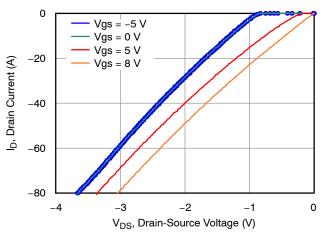


Figure 9. 3rd Quadrant Characteristics at T_J = –55 $^\circ\text{C}$

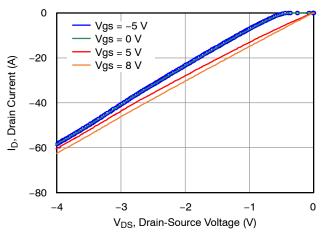
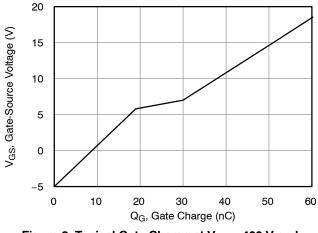
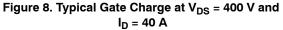


Figure 11. 3rd Quadrant Characteristics at T_J = 175 °C





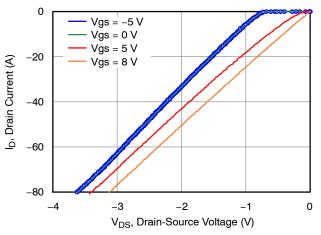
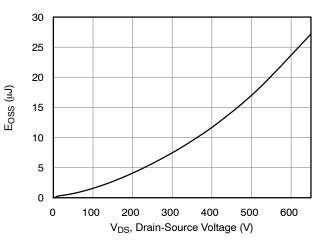
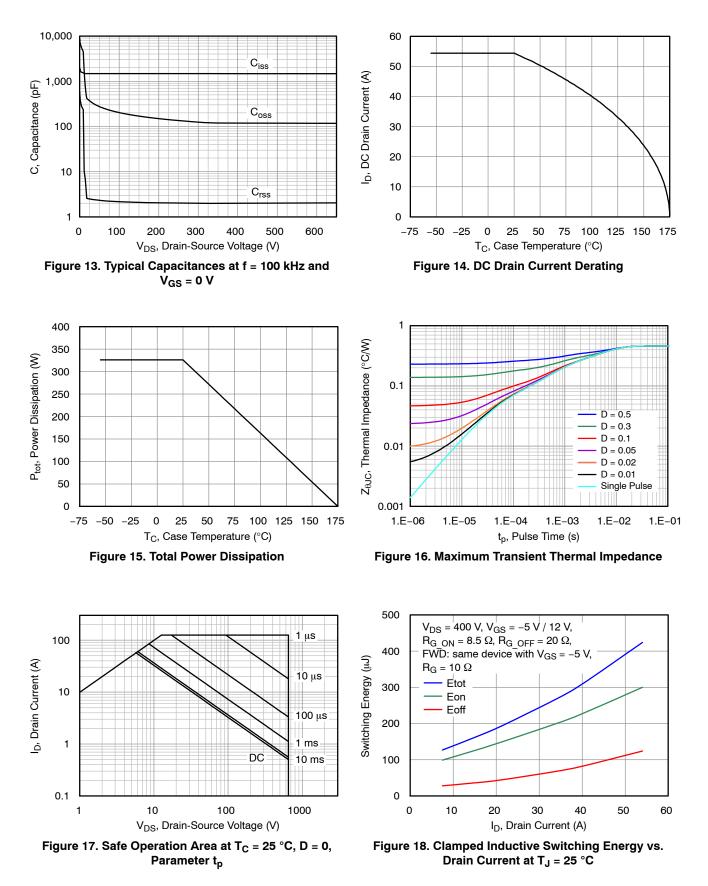


Figure 10. 3rd Quadrant Characteristics at T_J = 25 °C

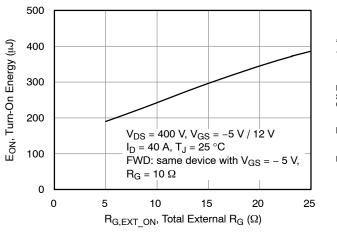


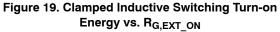


TYPICAL PERFORMANCE DIAGRAMS (CONTINUED)



TYPICAL PERFORMANCE DIAGRAMS (CONTINUED)





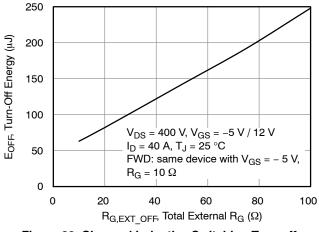
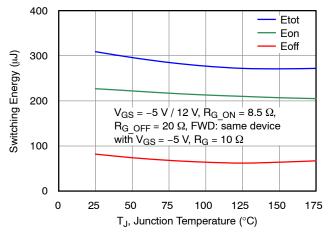
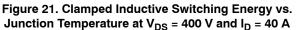


Figure 20. Clamped Inductive Switching Turn-off Energy vs. R_{G,EXT_OFF}





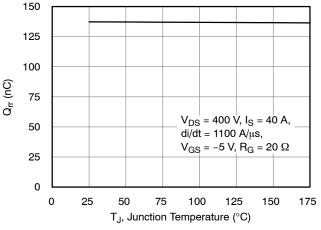


Figure 22. Reverse Recovery Charge Q_{rr} vs. Junction Temperature

APPLICATIONS INFORMATION

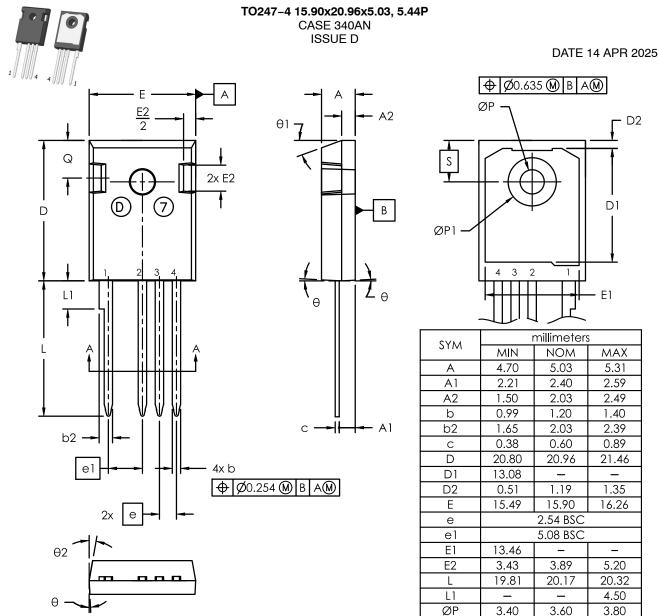
SiC cascodes are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{DS(on)}$), output capacitance (C_{oss}), gate charge (Q_G), and reverse recovery charge (Q_{rr}) leading to low conduction and switching losses. The SiC cascodes also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the cascode is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on cascode operation, see <u>www.onsemi.com</u>.

ORDERING INFORMATION

Part Number	Marking	Package	Shipping [†]
UF3C065040K4S	UF3C065040K4S	TO247-4 15.90x20.96x5.03, 5.44P (Pb-Free, Halogen Free)	600 / Tube

nsemi



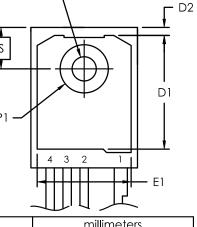
NOTE:

- 1. Dimensioning and tolerancing as per ASME Y14.5 2018
- 2. Controlling dimension : millimeters
- 3. Package Outline in compliance with JEDEC standard var. AD.
- Dimensions D & E does not include mold flash. 4.
- 5. ØP to have max draft angle of 1.7° to the top with max. hole diameter of 3.91mm.
- 5. Through Hole diameter value = End Hole diameter
- PCB Through Hole pattern as per IPC-2221/IPC-2222 6.

DOCUMENT NUMBER:	98AON86067F Electronic versions are uncontrolled except when accessed directly from the Document Repos Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.			
DESCRIPTION:	TO247–4 15.90x20.96x5.03, 5.44P		PAGE 1 OF 2	

onsemi and ONSEMi are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make charges without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products herein. special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

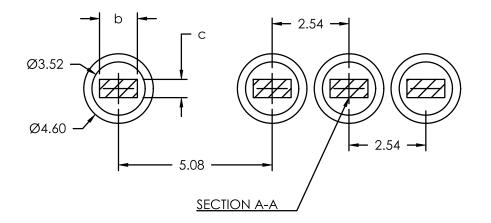
© Semiconductor Components Industries, LLC, 2025



SYM	millimeters					
3174	MIN	NOM	MAX			
А	4.70	5.03	5.31			
A1	2.21	2.40	2.59			
A2	1.50	2.03	2.49			
b	0.99	1.20	1.40			
b2	1.65	2.03	2.39			
С	0.38	0.60	0.89			
c D	20.80	20.96	21.46			
D1	13.08	-	-			
D2	0.51	1.19	1.35			
E	15.49	15.90	16.26			
е	2.54 BSC					
el		5.08 BSC				
E1	13.46	-	-			
E2	3.43	3.89	5.20			
L	19.81	20.17	20.32			
L1	1		4.50			
ØP	3.40	3.60	3.80			
ØP1	7.06	7.19	7.39			
Q	5.38	5.62	6.20			
S Đ	6.17 BSC					
θ		3°				
θ1		20°				
θ2		10°				

DATE 14 APR 2025

RECOMMENDED PCB THROUGH HOLE



NOTE: LAND PATTERN AND THROUGH HOLE DIMENSIONS SERVE ONLY AS AN INITIAL GUIDE. END-USER PCB DESIGN RULES AND TOLERANCES SHOULD ALWAYS PREVAIL.

DOCUMENT NUMBER:	98AON86067F Electronic versions are uncontrolled except when accessed directly from the Document Reposito Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.			
DESCRIPTION:	TO247-4 15.90x20.96x5.03, 5.44P		PAGE 2 OF 2	

onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product rights for circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent_Marking.pdf</u>. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or indental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification. Buyer shall indemnify and hold onsemi and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs,

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

Technical Library: www.onsemi.com/design/resources/technical-documentation onsemi Website: www.onsemi.com

ONLINE SUPPORT: <u>www.onsemi.com/support</u> For additional information, please contact your local Sales Representative at <u>www.onsemi.com/support/sales</u>